

<b>Notice of References Cited</b>	Application/Control No 09/857,695	Applicant(s)/Patent Under Reexamination KISO ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,939,309	08-1999	Suwa et al.	435/253.1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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#### FOREIGN PATENT DOCUMENTS

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	K	US-			
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	N	EP 382,355	08-1990	Europe	Mitsuhashi et al.	
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